Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/716,190	KOIDE ET AL.
Examiner	Art Unit
EDMUND H. LEE	1732

SEARCHED				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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updated		10/16/2006	EHL
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